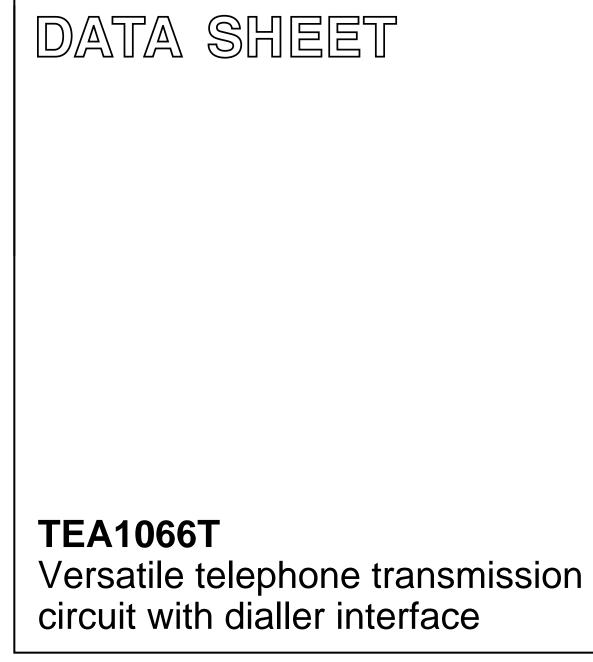
INTEGRATED CIRCUITS



Product specification Supersedes data of September 1990 File under Integrated Circuits, IC03 1996 Apr 04



TEA1066T

FEATURES

- Voltage regulator with adjustable static resistance
- Provides supply for external circuitry
- Symmetrical low-impedance inputs for dynamic and magnetic microphones
- Symmetrical high-impedance inputs for piezoelectric microphone
- Asymmetrical high-impedance input for electret microphone
- Dual-tone multi-frequency (DTMF) signal input with confidence tone
- Mute input for pulse or DTMF dialling

QUICK REFERENCE DATA

• Power down input for pulse dial or register recall

- Receiving amplifier for magnetic, dynamic or piezoelectric earpieces
- Large gain setting range on microphone and earpiece amplifiers
- Line loss compensation facility, line current dependent (microphone and earpiece amplifiers)
- · Gain control adaptable to exchange supply
- DC line voltage adjustment facility.

GENERAL DESCRIPTION

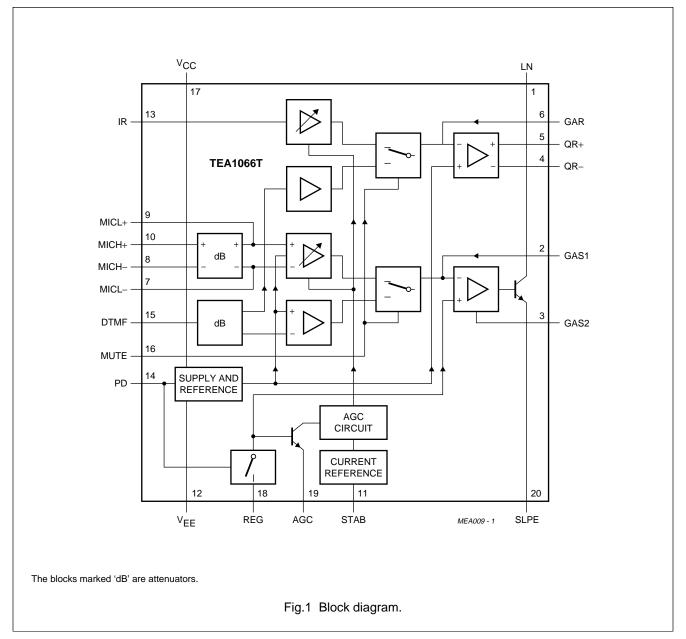
The TEA1066T is a bipolar integrated circuit that performs all speech and line interface functions required in fully electronic telephone sets. The circuit performs electronic switching between dialling and speech.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{LN}	line voltage	I _{line} = 15 mA	4.25	4.45	4.65	V
I _{line}	line current	normal operation	10	-	140	mA
I _{CC}	internal supply current	power down input LOW	-	0.96	1.3	mA
		power down input HIGH	-	55	82	μA
V _{CC}	supply voltage for peripherals	I _{line} = 15 mA; MUTE input HIGH; I _p = 1.2 mA	2.8	3.05	-	V
		$I_{line} = 15 \text{ mA; MUTE}$ input HIGH; $I_p = 1.7 \text{ mA}$	2.5	-	-	V
G _v	voltage gain range for microphone amplifier					
	low impedance inputs (pins 7 and 9)		44	-	60	dB
	high impedance inputs (pins 8 and 10)		30	-	46	dB
	receiving amplifier		17	-	39	dB
T _{amb}	operating ambient temperature		-25	_	+75	°C
Line loss co	ompensation	·				
ΔG_v	gain control		5.5	5.9	6.3	dB
V _{exch}	exchange supply voltage		24	_	60	V
R _{exch}	exchange feeding bridge resistance		400	_	1000	Ω
	•					

ORDERING INFORMATION

TYPE	PACKAGE		
NUMBER	NAME	DESCRIPTION	VERSION
TEA1066T	SO20	plastic small outline package; 20 leads; body width 7.5 mm	SOT163-1

BLOCK DIAGRAM



PINNING

SYMBOL	PIN	DESCRIPTION	
LN	1	positive line terminal	
GAS1	2	gain adjustment transmitting amplifier	
GAS2	3	gain adjustment transmitting amplifier	
QR-	4	inverting output receiving amplifier	
QR+	5	non-inverting output receiving amplifier	
GAR	6	gain adjustment receiving amplifier	
MICL-	7	inverting microphone input, low impedance	
MICH-	8	inverting microphone input, high impedance	
MICL+	9	non-inverting microphone input, low impedance	
MICH+	10	non-inverting microphone input, high impedance	
STAB	11	current stabilizer	
V _{EE}	12	negative line terminal	
IR	13	receiving amplifier input	
PD	14	power-down input	
DTMF	15	dual-tone multi-frequency input	
MUTE	16	mute input	
V _{CC}	17	supply voltage decoupling	
REG	18	voltage regulator decoupling	
AGC	19	automatic gain control input	
SLPE	20	slope (DC resistance) adjustment	

FUNCTIONAL DESCRIPTION

Supplies: V_{CC}, LN, SLPE, REG and STAB

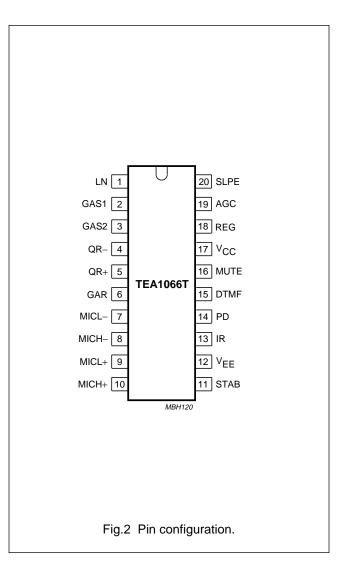
Power for the TEA1066T and its peripheral circuits is usually obtained from the telephone line. The TEA1066T develops its own supply voltage at V_{CC} and regulates its voltage drop. The supply voltage V_{CC} may also be used to supply external peripheral circuits, e.g. dialling and control circuits.

The supply has to be decoupled by connecting a smoothing capacitor between V_{CC} and V_{EE}; the internal voltage regulator has to be decoupled by a capacitor from REG to V_{EE}. An internal current stabilizer is set by a resistor of 3.6 k Ω between STAB and V_{EE}.

The DC current flowing into the set is determined by the exchange supply voltage (V_{exch}), the feeding bridge resistance (R_{exch}), the DC resistance of the telephone line (R_{line}) and the DC voltage on the subscriber set (see Fig.7).

If the line current I_{line} exceeds the current I_{CC} + 0.5 mA required by the circuit itself (approximately 1 mA) plus the current I_p required by the peripheral circuits connected to V_{CC} , then the voltage regulator diverts the excess current via LN.

Product specification



4

LN to:

 $V_{LN} = V_{ref} + (I_{line} - I_{CC} - 0.5 \times 10^{-3} \text{A} - I_{p}) \times \text{R9}$

The voltage regulator adjusts the average voltage on

where V_{ref} is an internally generated temperature compensated reference voltage of 4.2 V and R9 is an external resistor connected between SLPE and V_{EE}.

Versatile telephone transmission circuit

The preferred value for R9 is 20 Ω . Changing the value of R9 will also affect microphone gain, DTMF gain, gain control characteristics, side-tone level and the maximum output swing on LN.

Under normal conditions, when $I_{SLPE} >> I_{CC} + 0.5 \text{ mA} + I_{p}$, the static behaviour of the circuit is that of a 4.2 V regulator diode with an internal resistance equal to that of R9. In the audio frequency range, the dynamic impedance is largely determined by R1 (see Fig.3).

R9 C3 4.7 μF C1 20 Ω 100 uF V_{FF} o MBA454

The internal reference voltage can be adjusted by means of an external resistor R_{VA}. This resistor, connected between LN and REG (pins 1 and 18), will decrease the internal reference voltage; when connected between REG and SLPE (pins 18 and 20) it will increase the internal reference voltage.

Current I_p, available from V_{CC} for supplying peripheral circuits, depends on external components and on the line current. Figure 8 shows this current for V_{CC} > 2.2 V

and > 3 V, this being the minimum supply voltage for most CMOS circuits, including voltage drop for an enable diode. If MUTE is LOW, the available current is further reduced when the receiving amplifier is driven.

Microphone inputs MICL+, MICH+, MICL- and MICHand amplification adjustment connections GAS1 and GAS2

The TEA1066T has symmetrical microphone inputs. The MICL+ and MICL- inputs are intended for low-sensitivity, low-impedance dynamic or magnetic microphones. The input impedance is 8.2 k Ω (2 × 4.1 k Ω) and its voltage gain is typically 52 dB. The MICH+ and MICH- inputs are intended for a piezoelectric microphone or an electret microphone with a built-in FET source follower. Its input impedance is 40.8 k Ω (2 × 20.4 k Ω) and its voltage gain is typical 38 dB.

The arrangements with the microphone types mentioned are shown in Fig.9.

The gain of the microphone amplifier in both types can be adjusted over a range of ± 8 dB to suit the sensitivity of the transducer used. The gain is proportional to external resistor R7 connected between GAS1 and GAS2.

An external capacitor C6 of 100 pF between GAS1 and SLPE is required to ensure stability. A larger value may be chosen to obtain a first-order low-pass filter. The cut-off frequency corresponds with the time constant $R7 \times C6$.

Mute input MUTE

A HIGH level at MUTE enables the DTMF input and inhibits the microphone inputs and the receiving amplifier; a LOW level or an open circuit has the reverse effect. Switching the mute input will cause negligible clicks at the earpiece outputs and on the line.

Dual-tone multi frequency input DTMF

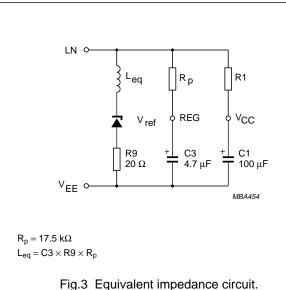
When the DTMF input is enabled, dialling tones may be sent onto the line. The voltage gain from DTMF to LN is typically 25.5 dB and varies with R7 in the same way as the gain of the microphone amplifier. The signalling tones can be heard in the earpiece at a low level (confidence tone).

Receiving amplifier: IR, QR+, QR- and GAR

The receiving amplifier has one input IR and two complementary outputs, a non-inverting output QR+ and an inverting output QR-.

with dialler interface

 $V_{LN} = V_{ref} + I_{SLPE} \times R9$



These outputs may be used for single-ended or for differential drive, depending on the sensitivity and type of earpiece used (see Fig.10). Gain from IR to QR+ is typically 25 dB. This will be sufficient for low-impedance magnetic or dynamic earpieces, which are suited for single-ended drive. By using both outputs (differential drive), the gain is increased by 6 dB and differential drive becomes possible. This feature can be used when the earpiece impedance exceeds 450 Ω (high-impedance dynamic, magnetic or piezoelectric earpieces).

The output voltage of the receiving amplifier is specified for continuous-wave drive. The maximum output voltage will be higher under speech conditions, where the ratio of peak to RMS value is higher.

The receiving amplifier gain can be adjusted over a range of ± 8 dB to suit the sensitivity of the transducer used. The gain is set by the external resistor R4 connected between GAR and QR+.

Two external capacitors, C4 = 100 pF and C7 = $10 \times C4 = 1$ nF, are necessary to ensure stability. A larger value of C4 may be chosen to obtain a first-order, low-pass filter. The 'cut-off' frequency corresponds with the time constant R4 × C4.

Automatic gain control input AGC

Automatic line loss compensation is obtained by connecting a resistor R6 between AGC and V_{EE} . This automatic gain control varies the microphone amplifier gain and the receiving amplifier gain in accordance with the DC line current.

The control range is 6 dB. This corresponds with a line length of 5 km for a 0.5 mm diameter copper twisted-pair cable with a DC resistance of 176 Ω /km and an average attenuation of 1.2 dB/km.

Resistor R6 should be chosen in accordance with the exchange supply voltage and its feeding bridge resistance (see Fig.11 and Table 1). Different values of R6 give the same ratio of line currents for start and end of the control range.

If automatic line loss compensation is not required, AGC may be left open. The amplifiers then all give their maximum gain as specified.

Power-down input PD

During pulse dialling or register recall (timed loop break) the telephone line is interrupted, as a consequence it provides no supply for the transmission circuit and the peripherals connected to V_{CC} . These gaps have to be

bridged by the charge in the smoothing capacitor C1. The requirements on this capacitor are relaxed by applying a HIGH level to the PD input during the time of the loop break, which reduces the supply current from typically 1 mA to typically $55 \,\mu$ A.

A HIGH level at PD further disconnects the capacitor at REG, with the effect that the voltage stabilizer will have no switch-on delay after line interruptions. This results in no contribution of the IC to the current waveform during pulse dialling or register recall. When this facility is not required PD may be left open.

Side-tone suppression

Suppression of the transmitted signal in the earpiece is obtained by the anti-side-tone network consisting of $R1//Z_{line}$, R2, R3, R8, R9 and Z_{bal} (see Fig.14). Maximum compensation is obtained when the following conditions are fulfilled:

$$R9 \times R2 = R1 (R3 + [R8//Z_{bal}])$$
 (1)

$$Z_{bal}/(Z_{bal}+R8) = Z_{line}/(Z_{line}+R1)$$
 (2)

If fixed values are chosen for R1, R2, R3, and R9, then condition (1) will always be fulfilled, provided that $|R8//Z_{bal}| < R3$. To obtain optimum side-tone suppression, condition (2) has to be fulfilled, resulting in:

$$\begin{split} Z_{bal} = (R8/R1) \; Z_{line} = k \times Z_{line}, \text{ where } k \text{ is a scale factor:} \\ k = (R8/R1). \end{split}$$

Scale factor k (dependent on the value of R8) must be chosen to meet the following criteria:

- 1. Compatibility with a standard capacitor from the E6 or E12 range for Z_{bal}
- 2. |Z_{bal}//R8| << R3
- 3. |Z_{bal} + R8| >> R9.

In practice, Z_{line} varies greatly with line length and cable type; consequently, an average value has to be chosen for Z_{bal} . The suppression further depends on the accuracy with which Z_{bal}/k equals the average line impedance.

Example: The balanced line impedance $|Z_{bal}|$ at which the optimum suppression is preset can be calculated by:

Assume $Z_{\text{line}} = 210 \ \Omega + (1265 \ \Omega/140 \ \text{nF})$, representing a 5 km line of 0.5 mm diameter, copper, twisted-pair cable matched to 600 Ω (176 Ω /km; 38 nF/km). When k = 0.64, then R8 = 390 Ω ; $Z_{\text{bal}} = 130 \ \Omega + (820 \ \Omega/220 \ \text{nF})$.

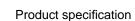
The anti-side-tone network for the TEA1060 family shown in Fig.4 attenuates the signal received from the line by 32 dB before it enters the receiving amplifier.

The attenuation is almost constant over the whole audio frequency range. Figure 5 shows a conventional Wheatstone bridge anti-side-tone circuit that can be used as an alternative. Both bridge types can be used with either resistive or complex set impedances.

Versatile telephone transmission circuit

The anti-side-tone network as used in the standard application (see Fig.13) attenuates the signal from the line with 32 dB. The attenuation is nearly flat over the audio-frequency range.

Instead of the previously-described special TEA1066 bridge, the conventional Wheatstone bridge configuration can be used as an alternative anti-side-tone circuit. Both bridge types can be used with either a resistive set impedance or a complex set impedance.





LN Z_{bal} R1 Z_{line} IR im V_{EE} R8 R9 R_A SLPE MSA501 - 1 Fig.5 Equivalent circuit of an anti-side-tone network in a Wheatstone bridge configuration.

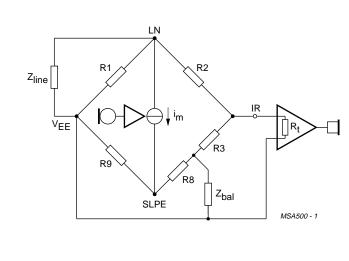


Fig.4 Equivalent circuit of TEA1060 family anti-side-tone bridge.

with dialler interface

TEA1066T

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

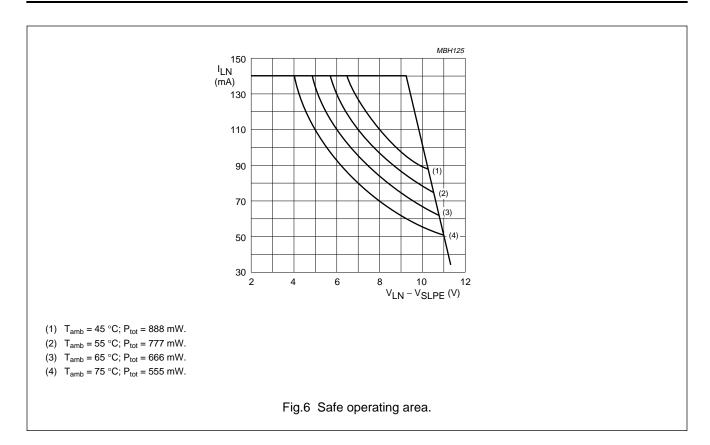
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{LN}	positive continuous line voltage		-	12	V
V _{LN(R)}	repetitive line voltage during switch-on or line interruption		-	13.2	V
V _{LN(RM)}	repetitive peak line voltage for a 1 ms pulse per 5 s	R9 = 20 Ω; R10 = 13 Ω; (Fig.10)	-	28	V
I _{line}	line current	R9 = 20 Ω; note 1	-	140	mA
V _n	voltage on any other pin		$V_{EE} - 0.7$	V _{CC} + 0.7	V
P _{tot}	total power dissipation	R9 = 20 Ω; note 2	_	555	mW
T _{stg}	IC storage temperature		-40	+125	°C
T _{amb}	operating ambient temperature		-25	+75	°C
Tj	junction temperature		_	125	°C

Notes

- 1. Mostly dependent on the maximum required T_{amb} and on the voltage between LN and SLPE (see Fig.6).
- 2. Calculated for the maximum ambient temperature specified, $T_{amb} = 75$ °C and a maximum junction temperature of 125 °C.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient in free air mounted on glass epoxy board 41 \times 19 \times 1.5 mm	90	K/W



CHARACTERISTICS

 I_{line} = 10 to 100 mA; V_{EE} = 0 V; f = 800 Hz; R9 = 20 Ω ; T_{amb} = 25 °C; unless otherwise specified.

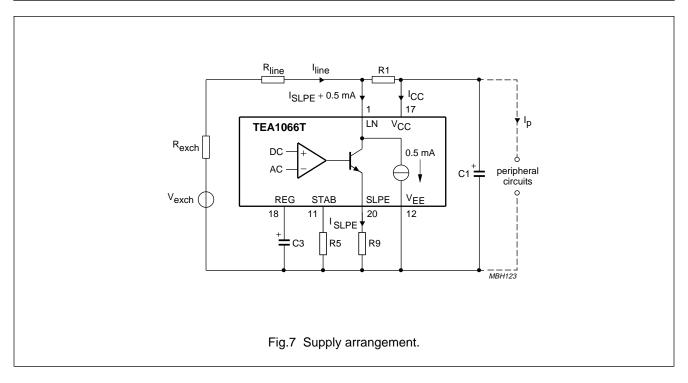
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supplies: L	N and V _{CC} (pins 1 and 17)					
V _{LN} voltage drop over circuit betw	voltage drop over circuit between	I _{line} = 5 mA	3.95	4.25	4.55	V
	LN and V _{EE}	I _{line} = 15 mA	4.25	4.45	4.65	V
	I _{line} = 100 mA	5.40	6.10	6.70	V	
		I _{line} = 140 mA	_	-	7.50	V
$\Delta V_{LN} / \Delta T$	voltage drop variation with temperature	I _{line} = 15 mA	-4	-2	0	mV/K
V _{LN}	voltage drop over circuit between LN and V_{EE} with external resistor	$I_{\text{line}} = 15 \text{ mA};$ $R_{\text{VA}} = \text{R1-18} = 68 \text{ k}\Omega$	3.50	3.80	4.05	V
	R _{VA}	$I_{\text{line}} = 15 \text{ mA};$ $R_{\text{VA}} = R18-20 = 39 \text{ k}\Omega$	4.70	5	5.30	V
I _{CC}	supply current	PD = LOW; V _{CC} = 2.8 V	_	0.96	1.30	mA
		$PD = HIGH; V_{CC} = 2.8 V$	_	55	82	μA
V _{CC}	supply voltage available for peripheral circuits	$I_{line} = 15 \text{ mA}; \text{ MUTE} = \text{HIGH};$ $I_p = 0 \text{ mA}$	3.50	3.75	-	V
		$I_{line} = 15 \text{ mA}; \text{ MUTE} = \text{HIGH};$ $I_p = 1.2 \text{ mA}$	2.80	3.05	-	V

Product specification

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Microphon	e inputs MICL+ and MICL-; MICH+ a	and MICH–			•	•
Z _i	input impedance					
	MICL+ (pin 9); MICL– (pin 7)		3.3	4.1	4.9	kΩ
	MICH+ (pin 10); MICH– (pin 8)		16.5	20.4	24.5	kΩ
CMRR	common mode rejection ratio		_	82	-	dB
G _v	voltage gain	I_{line} = 15 mA; R7 = 68 Ω				
	MICL+/MICL- to LN		51	52	53	dB
	MICH+/MICH- to LN		37	38	39	dB
ΔG_{vf}	gain variation with frequency at f = 300 Hz and 3400 Hz	with respect to 800 Hz	-0.5	±0.2	+0.5	dB
ΔG_{vT}	gain variation with temperature at $T_{amb} = -25 \text{ °C}$ and +75 °C	I _{line} = 50 mA; with respect to 800 Hz	-	±0.2	-	dB
Dual-tone	multi-frequency input DTMF (pin 15))				
Z _i	input impedance		16.8	20.7	24.6	kΩ
G _v	voltage gain from DTMF to LN	l _{line} = 15 mA; R7= 68 kΩ	24.5	25.5	26.5	dB
ΔG_{vf}	gain variation with frequency at f = 300 Hz and 3400 Hz	with respect to 800 Hz	-0.5	±0.2	+0.5	dB
ΔG_{vT}	gain variation with temperature at $T_{amb} = -25$ °C and +75 °C	I _{line} = 50 mA; with respect to 25 °C	-	±0.2	-	dB
Gain adjus	tment connections GAS1 and GAS2	2 (pins 2 and 3)			•	
ΔG_{v}	gain variation with R7, transmitting amplifier		-8	-	+8	dB
Transmittir	ng amplifier output LN (pin 1)	•	!		•	
V _{LN(rms)}	output voltage (RMS value)	I _{line} = 15 mA; THD = 2%	1.9	2.3	_	V
(- <i>1</i>		I _{line} = 15 mA; THD = 10%	_	2.6	-	V
V _{no(rms)}	noise output voltage (RMS value)	$I_{\text{line}} = 15 \text{ mA}; \text{ R7} = 68 \text{ k}\Omega;$ microphone inputs open; psophometrically weighted (P53 curve)	-	-70	-	dBmp
Receiving	amplifier input IR (pin 13)					
Z _i	input impedance		17	21	25	kΩ
Receiving	amplifier outputs QR+ and QR– (pin	is 5 and 4)	- 1			
Z _o	output impedance	single-ended	_	4	-	Ω
G _v	voltage gain from IR to QR+ or QR-	l _{line} = 15 mA; R4 = 100 kΩ				1
		single-ended; $R_L = 300 \Omega$	24	25	26	dB
		differential; $R_L = 600 \Omega$	30	31	32	dB
ΔG_{vf}	gain variation with frequency at f = 300 Hz and 3400 Hz	with respect to 800 Hz	-0.5	±0.2	+0.5	dB
ΔG_{vT}	gain variation with temperature at $T_{amb} = -25 \text{ °C}$ and +75 °C	I _{line} = 50 mA; with respect to 25 °C	-	±0.2	-	dB

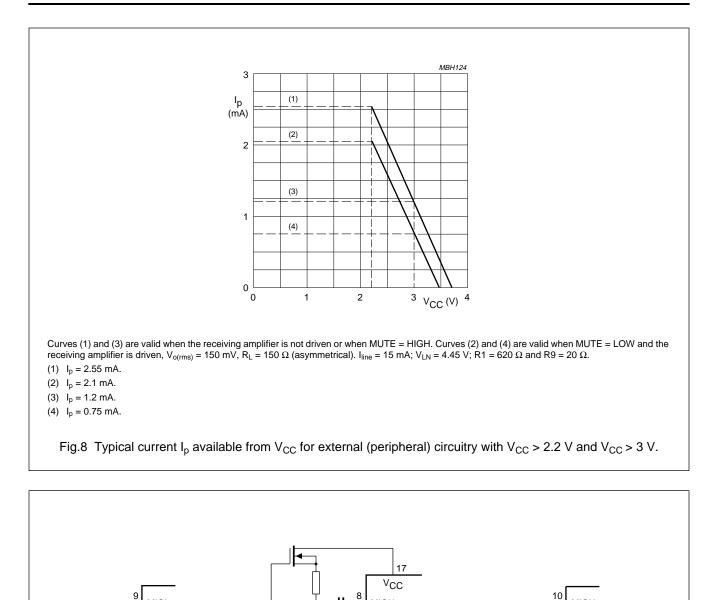
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{o(rms)}	output voltage (RMS value)	sine-wave drive; $I_{line} = 15 \text{ mA}$; $I_p = 0 \text{ mA}$; THD = 2%; R4 = 100 k Ω				
		single-ended; $R_L = 150 \Omega$	0.30	0.38	_	V
		single-ended; $R_L = 450 \ \Omega$	0.40	0.52	_	V
		differential; $C_L = 47 \text{ nF}$; $R_{\text{series}} = 100 \Omega$; f = 3400 Hz	0.80	1.0	-	V
V _{no(rms)}	noise output voltage (RMS value)	$I_{\text{line}} = 15 \text{ mA}; \text{ R4} = 100 \text{ k}\Omega;$ pin 13 (IR) open; psophometrically weighted (P53 curve)				
		single-ended; $R_L = 300 \ \Omega$	-	50	-	μV
		differential; $R_L = 600 \Omega$	-	100	-	μV
Gain adjus	tment GAR (pin 6)					
ΔG_v	gain variation with R4 connected between pin 6 and pin 5 receiving amplifier		-8	-	+8	dB
MUTE inpu	it (pin 16)					
VIH	HIGH level input voltage		1.50	-	V _{CC}	V
V _{IL}	LOW level input voltage		_	-	0.3	V
I _{MUTE}	input current		_	5	10	μA
ΔG_v	voltage gain reduction between MICL+ (pin 9) and MICL– (pin 7) to LN (pin 1)	MUTE = HIGH	-	70	-	dB
Gv	voltage gain from DTMF to QR+ or QR-	MUTE = HIGH; R4 = 100 k Ω ; single-ended; R _L = 300 Ω	-21	-19	-17	dB
Power-dow	vn input PD (pin 14)					
V _{IH}	HIGH level input voltage		1.5	-	V _{CC}	V
V _{IL}	LOW level input voltage		-	-	0.3	V
I _{PD}	input current in power-down condition		-	5	10	μA

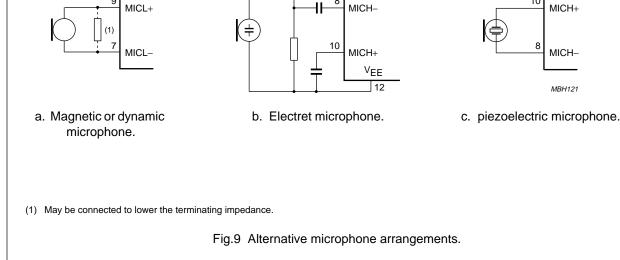
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Automatic	gain control input AGC (pin 19)	•	•	ł	•	•
ΔG_v	gain control range from IR to QR+/QR– and from MIC+/MIC– to LN	$I_{\text{line}} = 70 \text{ mA}; \text{R6} = 110 \text{ k}\Omega$ between AGC and V_{EE}	-5.5	-5.9	-6.3	dB
I _{line(H)}	highest line current for maximum gain	R6 = 110 k Ω between AGC and V _{EE}	-	23	-	mA
I _{line(L)}	lowest line current for minimum gain	R6 = 110 k Ω between AGC and V _{EE}	-	61	-	mA
ΔG_v	voltage gain variation	between I_{line} = 15 mA and I_{line} = 35 mA; R6 = 110 k Ω between AGC and V _{EE}	-1.0	-1.5	-2.0	dB

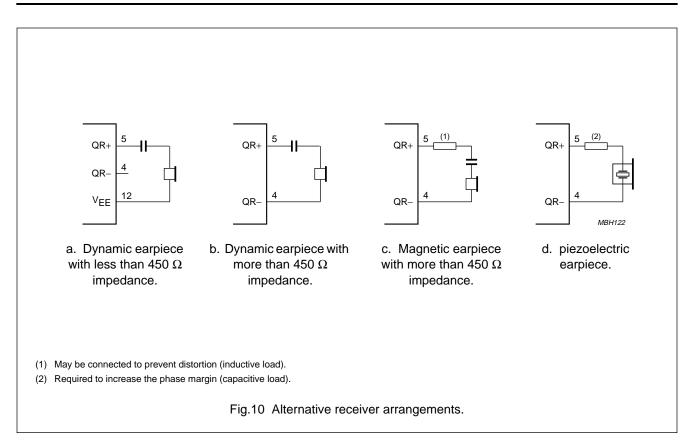


TEA1066T

Versatile telephone transmission circuit with dialler interface







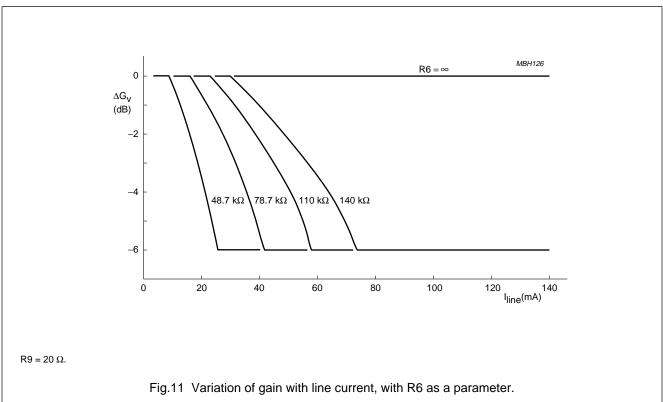
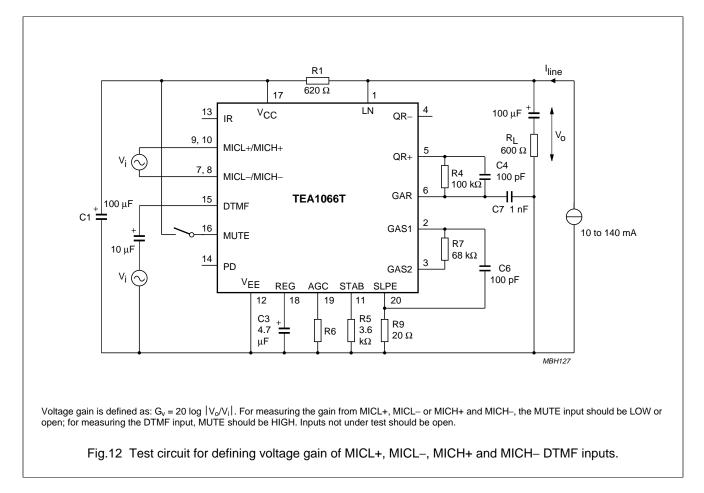
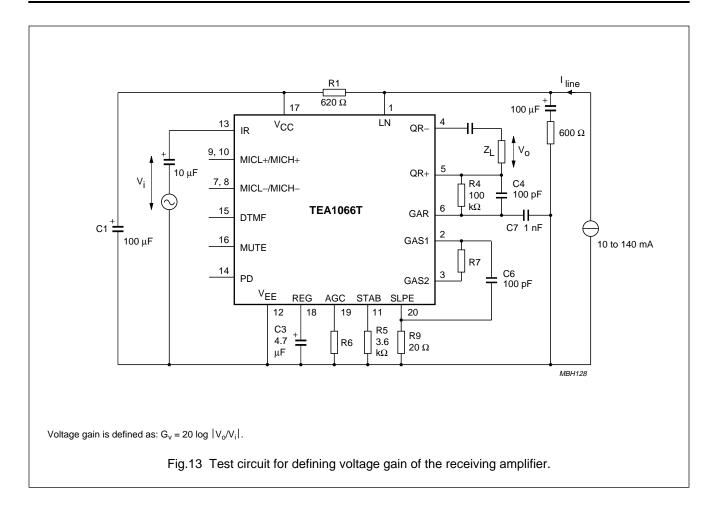


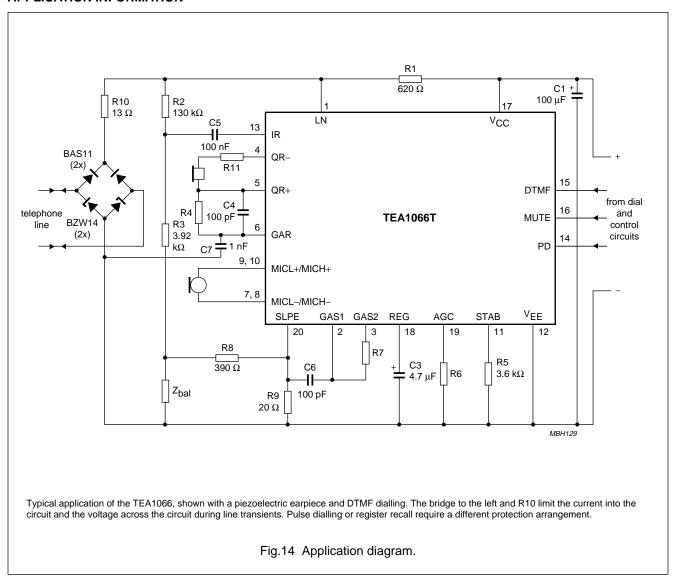
Table 1Values of resistor R6 for optimum line loss compensation, for various usual values of exchange supply
voltage V_{exch} and exchange feeding bridge resistance R_{exch} ; R9 = 20 Ω

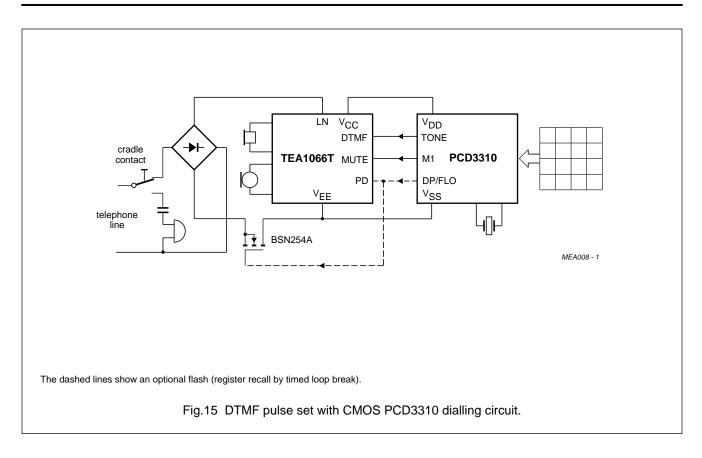
	R6 (kΩ)			
V _{exch} (V)	R _{exch} = 400 Ω	R _{exch} = 600 Ω	R _{exch} = 800 Ω	R_{exch} = 1000 Ω
24	61.9	48.7	Х	Х
36	100	78.7	68	60.4
48	140	110	93.1	82
60	X	Х	120	102



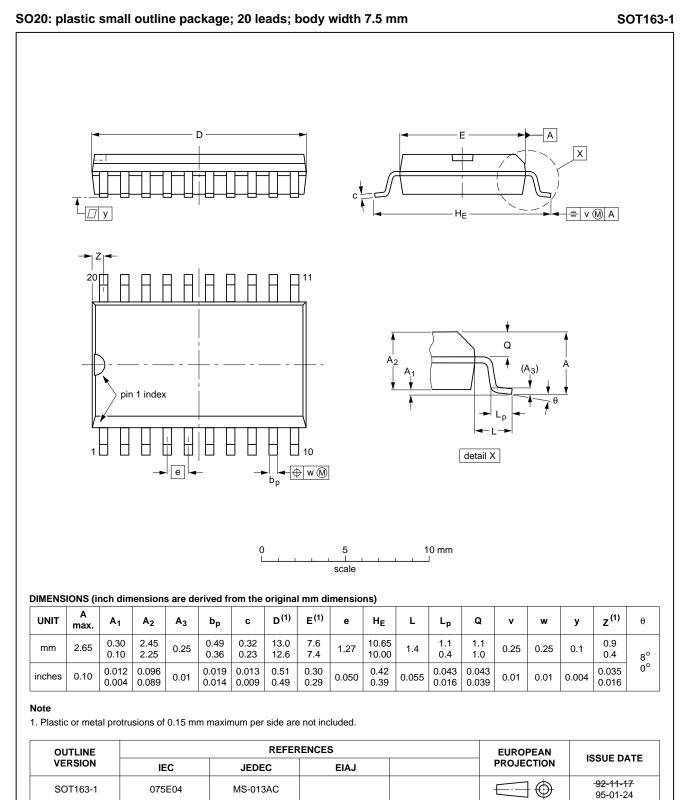


APPLICATION INFORMATION





PACKAGE OUTLINE



TEA1066T

SOLDERING

Introduction

There is no soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and surface mounted components are mixed on one printed-circuit board. However, wave soldering is not always suitable for surface mounted ICs, or for printed-circuits with high population densities. In these situations reflow soldering is often used.

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *"IC Package Databook"* (order code 9398 652 90011).

Reflow soldering

Reflow soldering techniques are suitable for all SO packages.

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several techniques exist for reflowing; for example, thermal conduction by heated belt. Dwell times vary between 50 and 300 seconds depending on heating method. Typical reflow temperatures range from 215 to 250 °C.

Preheating is necessary to dry the paste and evaporate the binding agent. Preheating duration: 45 minutes at 45 $^{\circ}$ C.

Wave soldering

Wave soldering techniques can be used for all SO packages if the following conditions are observed:

- A double-wave (a turbulent wave with high upward pressure followed by a smooth laminar wave) soldering technique should be used.
- The longitudinal axis of the package footprint must be parallel to the solder flow.
- The package footprint must incorporate solder thieves at the downstream end.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Maximum permissible solder temperature is 260 °C, and maximum duration of package immersion in solder is 10 seconds, if cooled to less than 150 °C within 6 seconds. Typical dwell time is 4 seconds at 250 °C.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

Repairing soldered joints

Fix the component by first soldering two diagonallyopposite end leads. Use only a low voltage soldering iron (less than 24 V) applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C. When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 °C.

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DEFINITIONS

Data sheet status			
Objective specification	This data sheet contains target or goal specifications for product development.		
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.		
Product specification	This data sheet contains final product specifications.		
Limiting values			
more of the limiting values n of the device at these or at a	accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or hay cause permanent damage to the device. These are stress ratings only and operation any other conditions above those given in the Characteristics sections of the specification miting values for extended periods may affect device reliability.		
Application information			
Where application information	on is given, it is advisory and does not form part of the specification.		

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

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